## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAKATANI ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,405,301 A	04-1995	Yagi et al.	477/120
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60145431 A	07-1985	Japan	YANAGISAWA et al.	F02D 29/04
	0	JP 07280054 A	10-1995	Japan	SAYAMA, MASAYUKI	F16H 09/00
	Р	JP 2003182407 A	07-2003	Japan	MIYAMOTO et al.	B60K 41/12
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	×					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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